

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/620,907	KOIDE ET AL.	
	<b>Examiner</b> Sung H. Pak	<b>Art Unit</b> 2874	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
385	134,139	5/13/2005	SP
385	147	5/13/2005	SP